

SN54AHCT74, SN74AHCT74 DUAL POSITIVE-EDGE-TRIGGERED D-TYPE FLIP-FLOPS WITH CLEAR AND PRESET

SCLS263K – DECEMBER 1995 – REVISED JANUARY 2000

- **EPIC™ (Enhanced-Performance Implanted CMOS) Process**
- **Inputs Are TTL-Voltage Compatible**
- **Latch-Up Performance Exceeds 250 mA Per JESD 17**
- **ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)**
- **Package Options Include Plastic Small-Outline (D), Shrink Small-Outline (DB), Thin Very Small-Outline (DGV), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) DIPs**

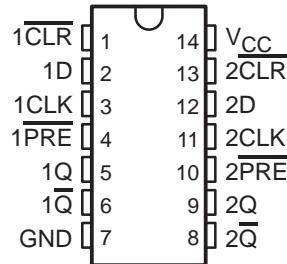
description

The 'AHCT74 dual positive-edge-triggered devices are D-type flip-flops.

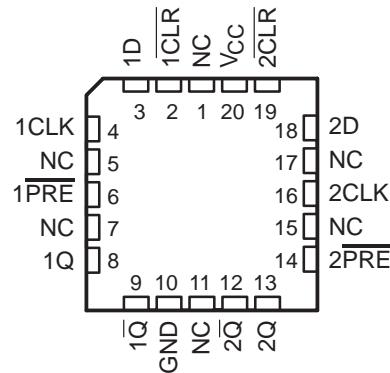
A low level at the preset ($\overline{\text{PRE}}$) or clear ($\overline{\text{CLR}}$) inputs sets or resets the outputs, regardless of the levels of the other inputs. When $\overline{\text{PRE}}$ and $\overline{\text{CLR}}$ are inactive (high), data at the data (D) input meeting the setup time requirements is transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of the clock pulse. Following the hold-time interval, data at the D input can be changed without affecting the levels at the outputs.

The SN54AHCT74 is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74AHCT74 is characterized for operation from -40°C to 85°C .

SN54AHCT74 . . . J OR W PACKAGE
SN74AHCT74 . . . D, DB, DGV, N, OR PW PACKAGE
(TOP VIEW)



SN54AHCT74 . . . FK PACKAGE
(TOP VIEW)



NC – No internal connection

FUNCTION TABLE
(each flip-flop)

INPUTS				OUTPUTS	
PRE	CLR	CLK	D	Q	\overline{Q}
L	H	X	X	H	L
H	L	X	X	L	H
L	L	X	X	H [†]	H [†]
H	H	↑	H	H	L
H	H	↑	L	L	H
H	H	L	X	Q ₀	\overline{Q}_0

[†]This configuration is unstable; that is, it does not persist when PRE or CLR returns to its inactive (high) level.

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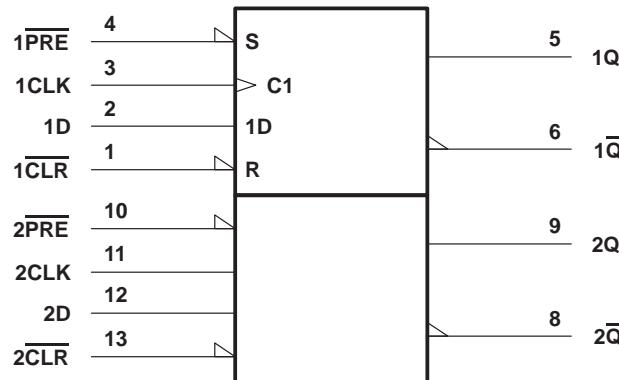
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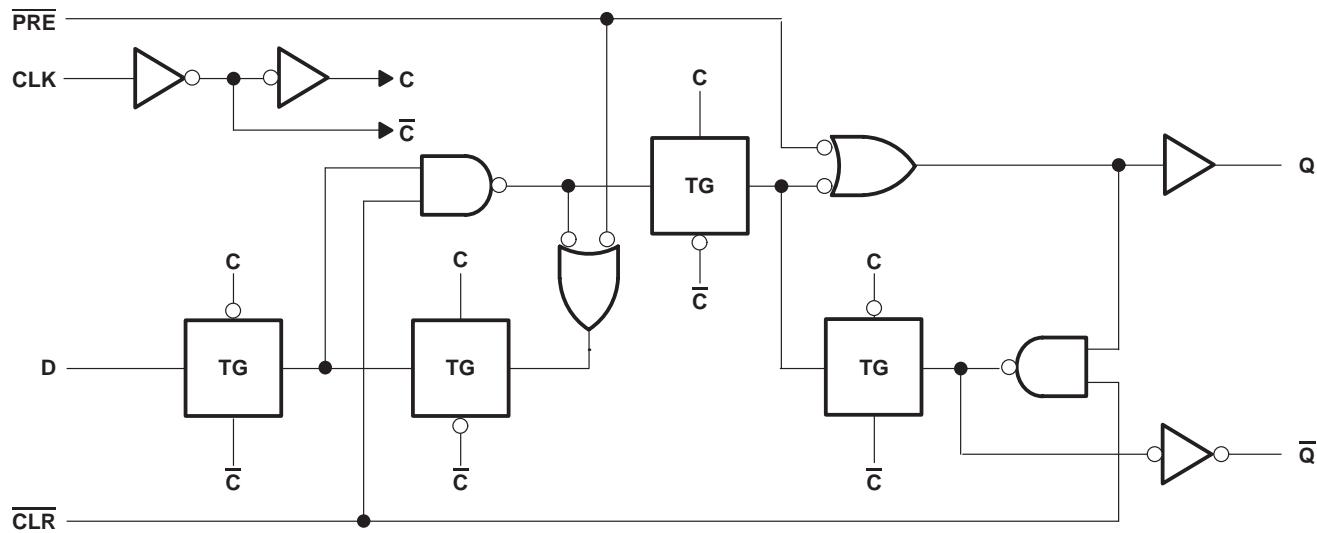
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logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
Pin numbers shown are for the D, DB, DGV, J, N, PW, and W packages.

logic diagram, each flip-flop (positive logic)



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V_{CC}	-0.5 V to 7 V	
Input voltage range, V_I (see Note 1)	-0.5 V to 7 V	
Output voltage range, V_O (see Note 1)	-0.5 V to V_{CC} + 0.5 V	
Input clamp current, I_{IK} ($V_I < 0$)	-20 mA	
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±20 mA	
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±25 mA	
Continuous current through V_{CC} or GND	±50 mA	
Package thermal impedance, θ_{JA} (see Note 2): D package	86°C/W	
DB package	96°C/W	
DGV package	127°C/W	
N package	80°C/W	
PW package	113°C/W	
Storage temperature range, T_{STG}	-65°C to 150°C	

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
 2. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions (see Note 3)

		SN54AHCT74		SN74AHCT74		UNIT
		MIN	MAX	MIN	MAX	
V_{CC}	Supply voltage	4.5	5.5	4.5	5.5	V
V_{IH}	High-level input voltage	2		2		V
V_{IL}	Low-level input voltage		0.8		0.8	V
V_I	Input voltage	0	5.5	0	5.5	V
V_O	Output voltage	0	V_{CC}	0	V_{CC}	V
I_{OH}	High-level output current		-8		-8	mA
I_{OL}	Low-level output current		8		8	mA
$\Delta t/\Delta V$	Input transition rise or fall rate		20		20	ns/V
T_A	Operating free-air temperature	-55	125	-40	85	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	T _A = 25°C			SN54AHCT74	SN74AHCT74	UNIT
			MIN	TYP	MAX	MIN	MAX	
V _{OH}	I _{OH} = -50 µA	4.5 V	4.4	4.5		4.4	4.4	V
	I _{OH} = -8 mA		3.94			3.8	3.8	
V _{OL}	I _{OL} = 50 µA	4.5 V		0.1		0.1	0.1	V
	I _{OL} = 8 mA			0.36		0.44	0.44	
I _I	V _I = V _{CC} or GND	0 V to 5.5 V		±0.1		±1*	±1	µA
I _{CC}	V _I = V _{CC} or GND, I _O = 0	5.5 V		2		20	20	µA
ΔI _{CC} [†]	One input at 3.4 V, Other inputs at V _{CC} or GND	5.5 V		1.35		1.5	1.5	mA
C _i	V _I = V _{CC} or GND	5 V	2	10			10	pF

* On products compliant to MIL-PRF-38535, this parameter is not production tested at V_{CC} = 0 V.

† This is the increase in supply current for each input at one of the specified TTL voltage levels rather than 0 V or V_{CC}.

timing requirements over recommended operating free-air temperature range, V_{CC} = 5 V ± 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	T _A = 25°C	SN54AHCT74	SN74AHCT74	UNIT
		MIN	MAX	
t _w Pulse duration	PRE or CLR low	5	5	ns
	CLK	5	5	
t _{su} Setup time before CLK↑	Data	5	5	ns
	PRE or CLR inactive	3.5	3.5	
t _h Hold time, data after CLK↑		0	0	ns

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V ± 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	T _A = 25°C			SN54AHCT74	SN74AHCT74	UNIT
				MIN	TYP	MAX	MIN	MAX	
f _{max}			C _L = 15 pF	100**	160**		80**	80	MHz
			C _L = 50 pF	80	140		65	65	
t _{PLH}	PRE or CLR	Q or \overline{Q}	C _L = 15 pF	7.6**	10.4**		1**	12**	ns
				7.6**	10.4**		1**	12**	
t _{PLH}	CLK	Q or \overline{Q}	C _L = 15 pF	5.8**	7.8**		1**	9**	ns
				5.8**	7.8**		1**	9**	
t _{PLH}	PRE or CLR	Q or \overline{Q}	C _L = 50 pF	8.1	11.4		1	13	ns
				8.1	11.4		1	13	
t _{PLH}	CLK	Q or \overline{Q}	C _L = 50 pF	6.3	8.8		1	10	ns
				6.3	8.8		1	10	

** On products compliant to MIL-PRF-38535, this parameter is not production tested.

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noise characteristics, $V_{CC} = 5$ V, $C_L = 50$ pF, $T_A = 25^\circ\text{C}$ (see Note 4)

PARAMETER	SN74AHCT74		UNIT
	MIN	MAX	
$V_{OL(P)}$ Quiet output, maximum dynamic V_{OL}		0.8	V
$V_{OL(V)}$ Quiet output, minimum dynamic V_{OL}		-0.8	V
$V_{OH(V)}$ Quiet output, minimum dynamic V_{OH}	4		V
$V_{IH(D)}$ High-level dynamic input voltage	2		V
$V_{IL(D)}$ Low-level dynamic input voltage		0.8	V

NOTE 4: Characteristics are for surface-mount packages only.

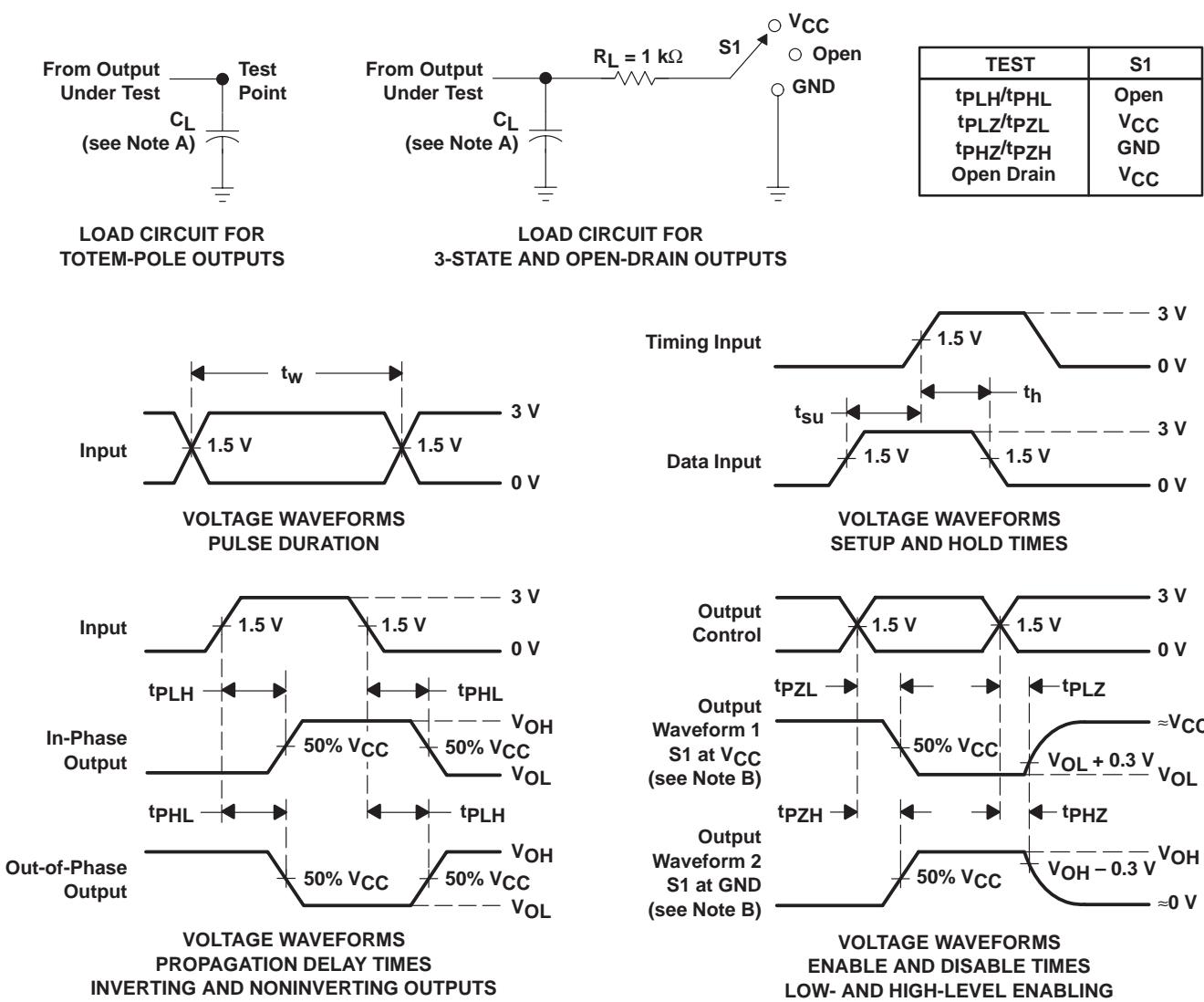
operating characteristics, $V_{CC} = 5$ V, $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	TYP	UNIT
C_{pd} Power dissipation capacitance	No load, $f = 1$ MHz	32	pF

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PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.
 B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 C. All input pulses are supplied by generators having the following characteristics: $PRR \leq 1 \text{ MHz}$, $Z_O = 50 \Omega$, $t_r \leq 3 \text{ ns}$, $t_f \leq 3 \text{ ns}$.
 D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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